Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/625,631	ITO ET AL.		
Examiner	Art Unit	_	
Sun J. Lin	2825		

	SEARCHED				
Class	Subclass	Date	Examiner		
716	11	3/16/2006	JSL		
716	8	3/16/2006	JSL		
716	9	3/16/2006	JSL		
716	10	3/16/2006	JSL		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	3/16/2006	JSL		
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